



INFORMATION DISCLOSURE  
STATEMENT BY APPLICANT  
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10434/60901

SERIAL NO.  
10/699,097

APPLICANT:  
HUANG et al.  
FILING DATE  
October 30, 2003

GROUP  
2878

U. S. PATENT DOCUMENTS

EXAMINER INITIAL	PATENT NUMBER	PATENT DATE	NAME	CLASS	SUBCLASS	FILING DATE*
ADF	6,203,683	March 20, 2001	Austin et al.			
ADF	4,959,133	September 25, 1990	Adock, M.W.			

FOREIGN PATENT DOCUMENTS

EXAMINER INITIAL	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
						YES	NO

OTHER DOCUMENTS

EXAMINER INITIAL	AUTHOR, TITLE, DATE, PERTINENT PAGES, ETC.	
ADF	Huang, L.R., Silberzan, P., Tegenfeldt, J.O., Cox, e.C., Strum, J.C., Austin, R.H. and Craighead, H. Role, Phys. Rev. Lett. 89, 178301 (2002)	
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EXAMINER

/Anthony Fick/ ADF

DATE CONSIDERED

06/09/2006

EXAMINER: Initial if citation considered, whether or not citation is in conformance with M.P.E.P. 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

Substitute for form 1449/PTO  <b>INFORMATION DISCLOSURE</b> <b>STATEMENT BY APPLICANT</b> (Use as many sheets as necessary)		O I P E MAY 18 2006 TRADEMARK OFFICE		<b>Complete if Known</b>			
		Application Number		10/699,097			
		Filing Date		October 30, 2003			
		First Named Inventor		HUANG			
		Art Unit		1742			
		Examiner Name		Lois L. ZHENG			
Sheet	1	of	1	Attorney Docket Number		10434/60901	

## U. S. PATENT DOCUMENTS

Examiner Initials*	Cite No. <sup>1</sup>	Document Number	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
		Number-Kind Code <sup>2</sup> (if known)			
ADF		US-6,766,817	07-27-2004	da Silva	
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## FOREIGN PATENT DOCUMENTS

Examiner Initials*	Cite No. <sup>1</sup>	Foreign Patent Document	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear	T <sup>6</sup>
		Country Code <sup>3</sup> , Number <sup>4</sup> , Kind Code <sup>5</sup> (if known)				

## OTHER PRIOR ART - NON PATENT LITERATURE DOCUMENTS

Examiner Initials*	Cite No.	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	T <sup>6</sup>

Examiner	/Anthony Fick/ ADF	Date considered	06/09/2006
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